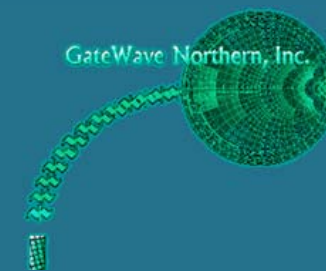


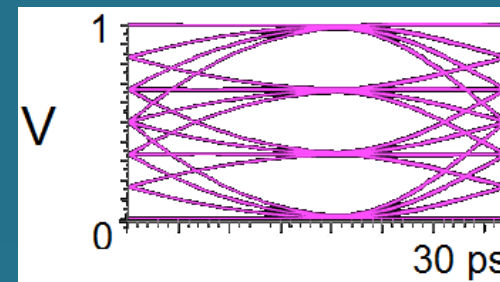
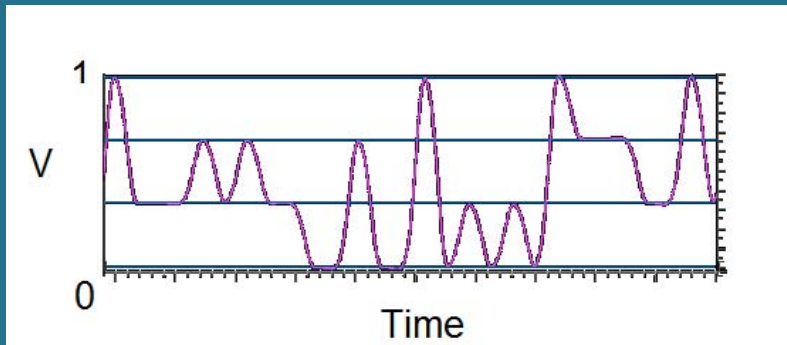
Crosstalk - the other PAM4 constraint

Gert Hohenwarter
GateWave Northern, Inc.



Problem

- Crosstalk -> Signal appears on adjacent lines
- Why has crosstalk become more important ?
 - 4-level signaling leads to reduced margins:



- Increase in operating frequencies often worsens crosstalk

Crosstalk

- *Forward crosstalk* aka FEXT (far-end XT)
 - In direction of signal travel
 - Generally this is the one to worry about
- *Backward crosstalk* aka NEXE (near-end XT)
 - Against direction of signal travel
 - Less significant if source well terminated and not an active receiver input

Objective

- Define relevant crosstalk
- Identify contributors
- Examine impact of design and design parameters
- Foster better understanding of constraints
- High frequency operation



Crosstalk - the other PAM4 constraint

4 2020

Approach

- Set up example socket model
- Examine performance via 3D field analysis
 - begin with single ended configurations
 - Develop basic understanding of contributors
 - Vary parameters to find sensitivity
 - expand to high speed differential configurations
 - Evaluate options for crosstalk reduction
- Identify PCB contributions



Relevant Socket Parameters

- Ground locations
- Pitch
- Contact length
- Contact lateral dimensions
- Housing construction (metal vs. dielectric)
- Housing material, e.g. dielectric constant

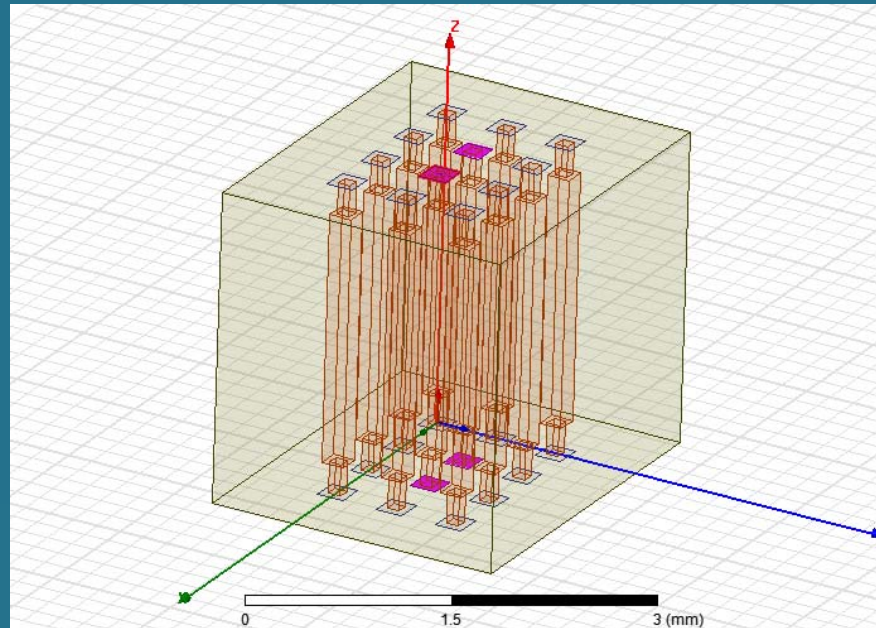
Only parameter examples that affect crosstalk are listed



Crosstalk - the other PAM4 constraint

6 2020

Single-ended line crosstalk model



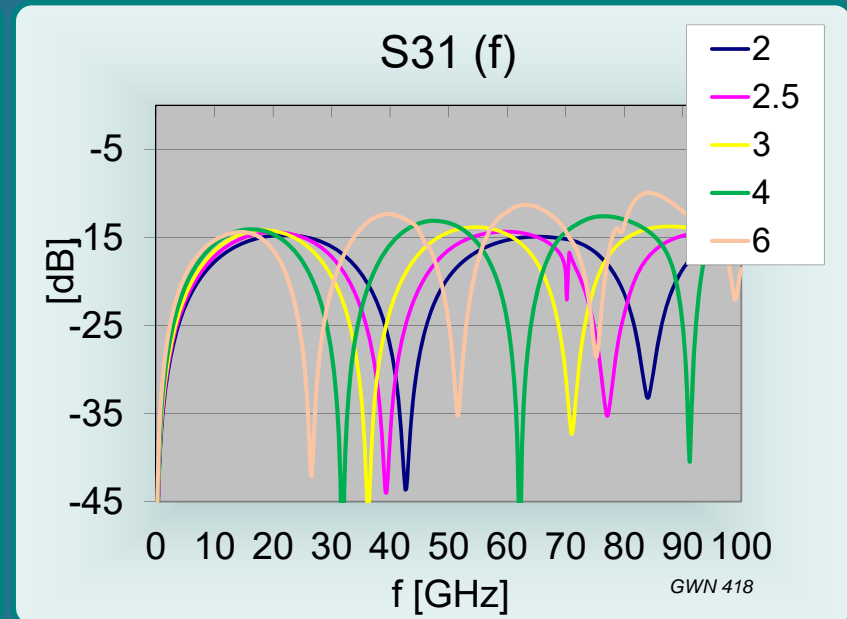
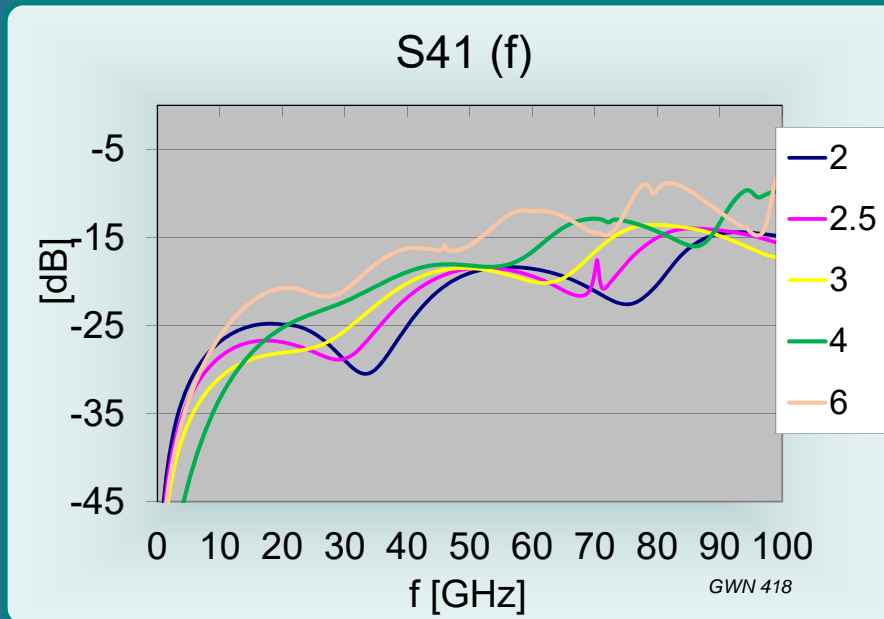
Coupling between two adjacent pins carrying individual unrelated signals



Crosstalk - the other PAM4 constraint

7 2020

FEXT and NEXT as a function of dielectric constant

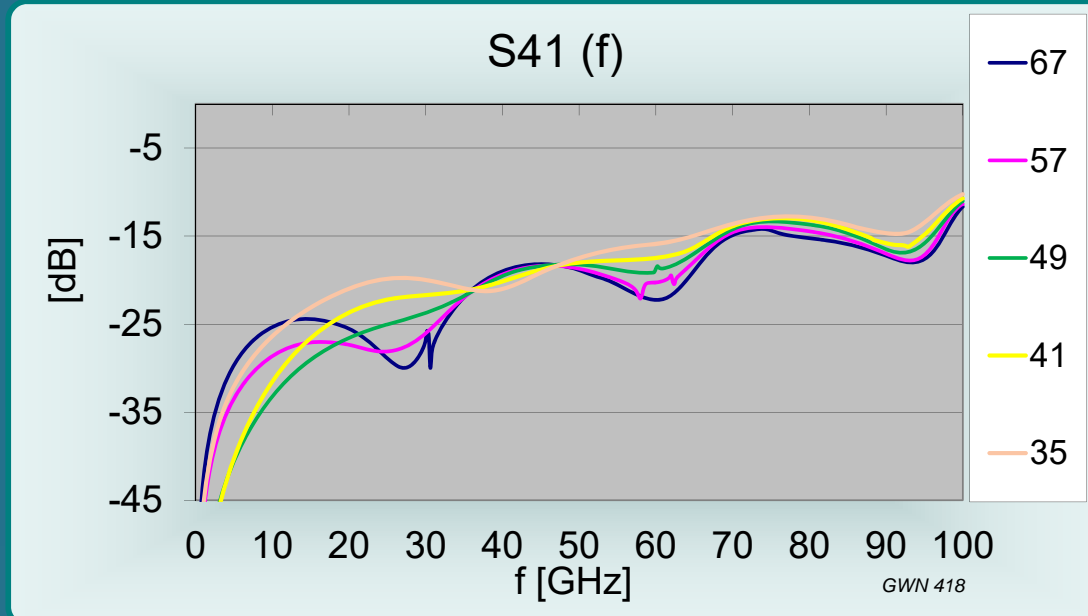


FEXT -> noticeable variability (Z_0 changes)

NEXT -> only small changes below 20 GHz

(Z_0 will vary depending on dielectric constant)

FEXT as a function of impedance

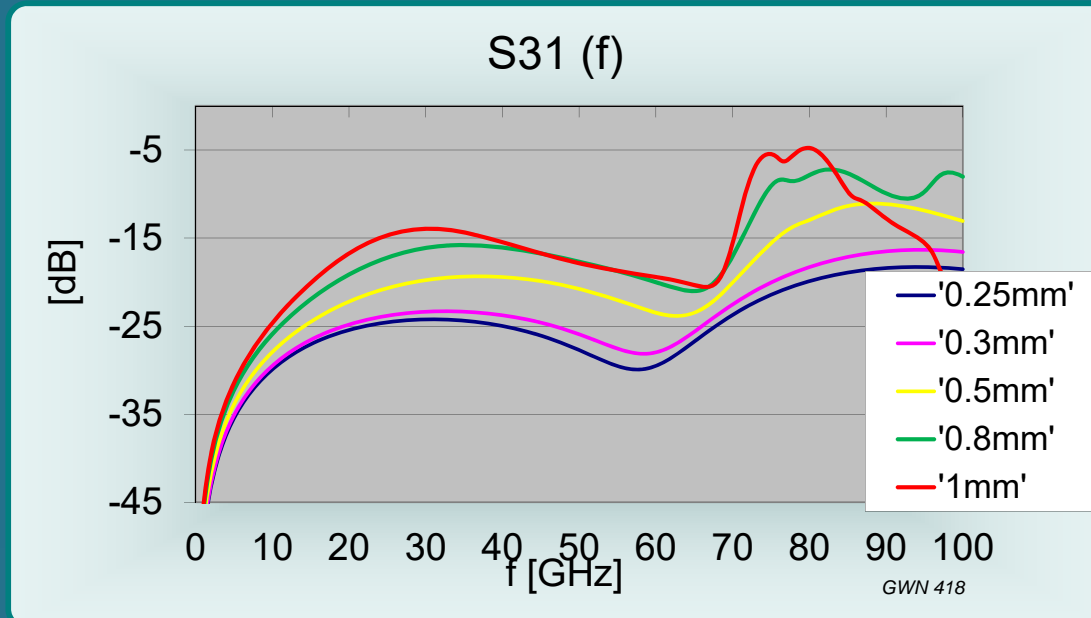


All cases:

- Constant pitch
- Identical height

Smoothest overall performance at Z=49 Ohms

NEXT as a function of length

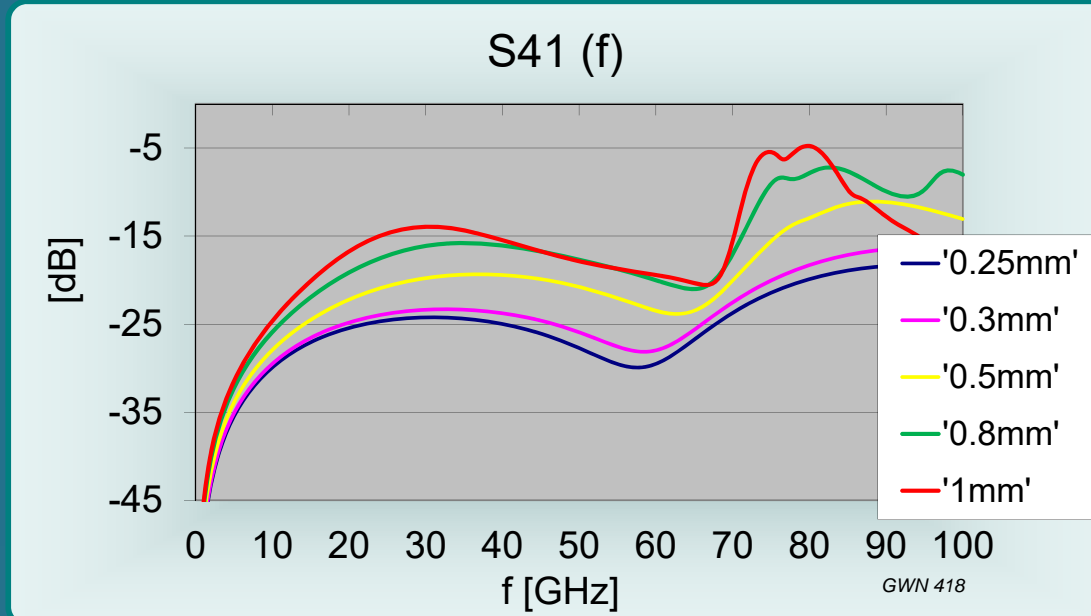


All cases:

- $Z_0 \sim 50$ Ohms
- Identical pitch

FEXT does not change appreciably with length (not shown)

FEXT as a function of pitch

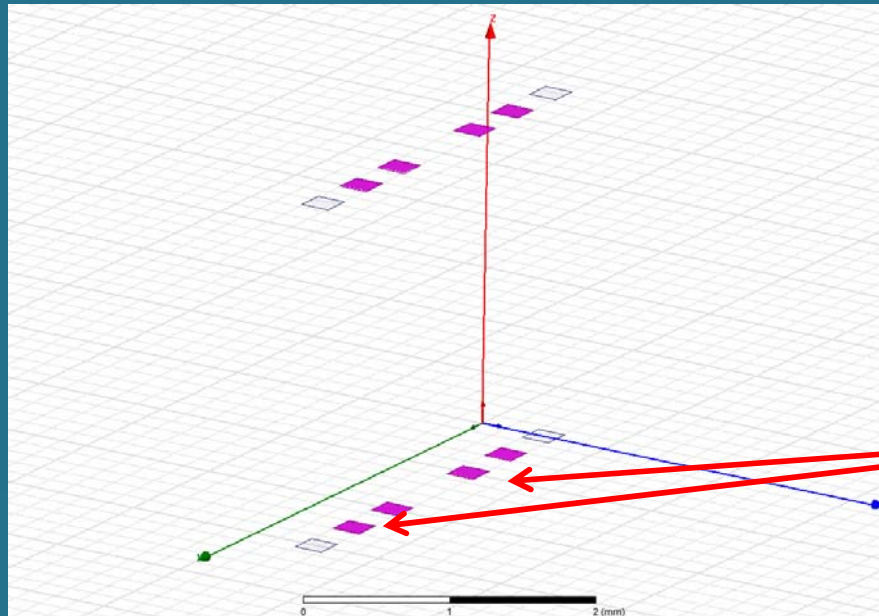


All cases:

- $Z_0 \sim 50$ Ohms
- Identical height

Lowest FEXT for smallest pitch
(however, no significant changes for NEXT)

Differential crosstalk as a function of pitch (edge configuration)



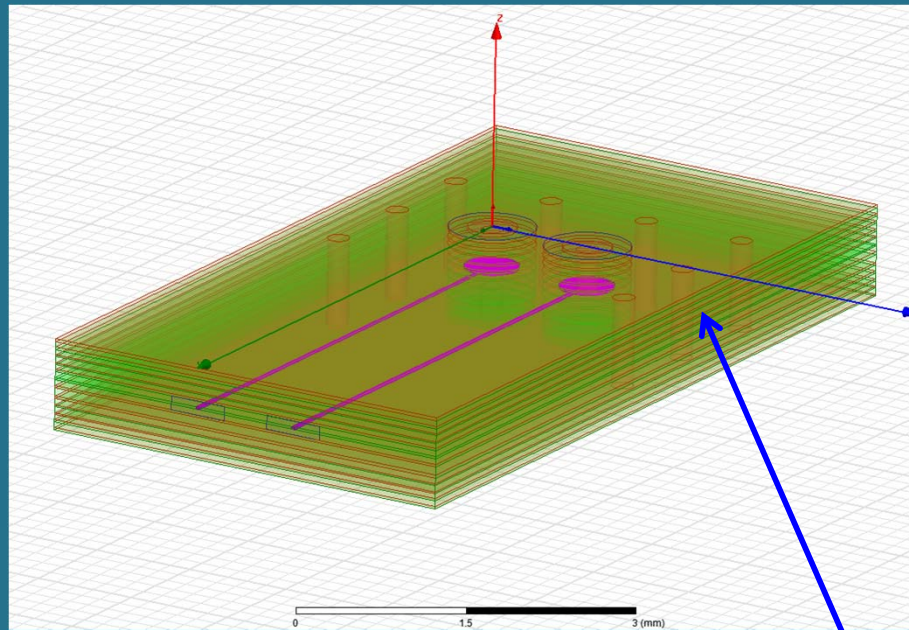
2 edge pairs without ground between signals

Differential crosstalk as a function of pitch



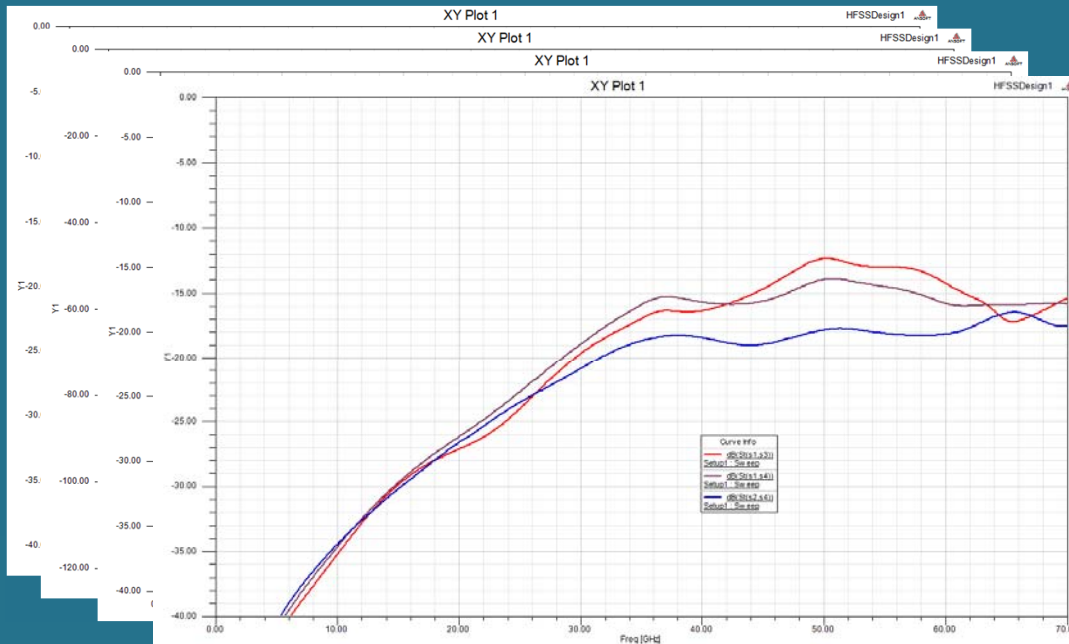
In this case, too, crosstalk increases with increasing pitch

Interactions with PCB routing



Stripline example with optional ground vias

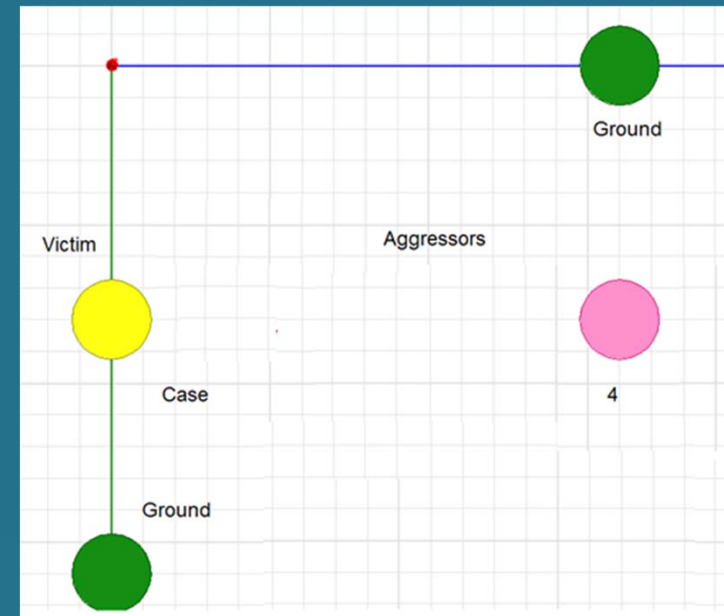
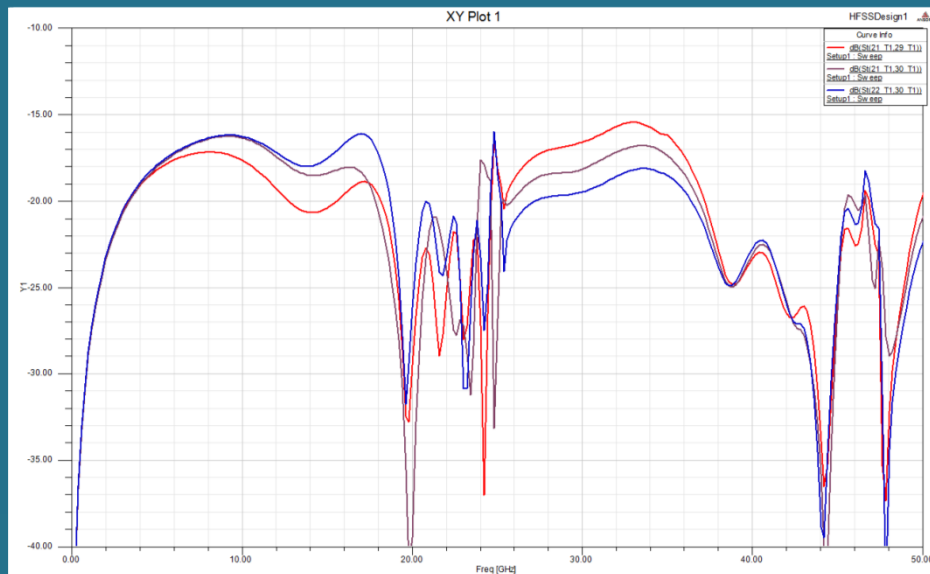
Crosstalk as a function of PCB features



- 1,2 – traces only
- 3 – signal vias only
- 4 – with ground vias

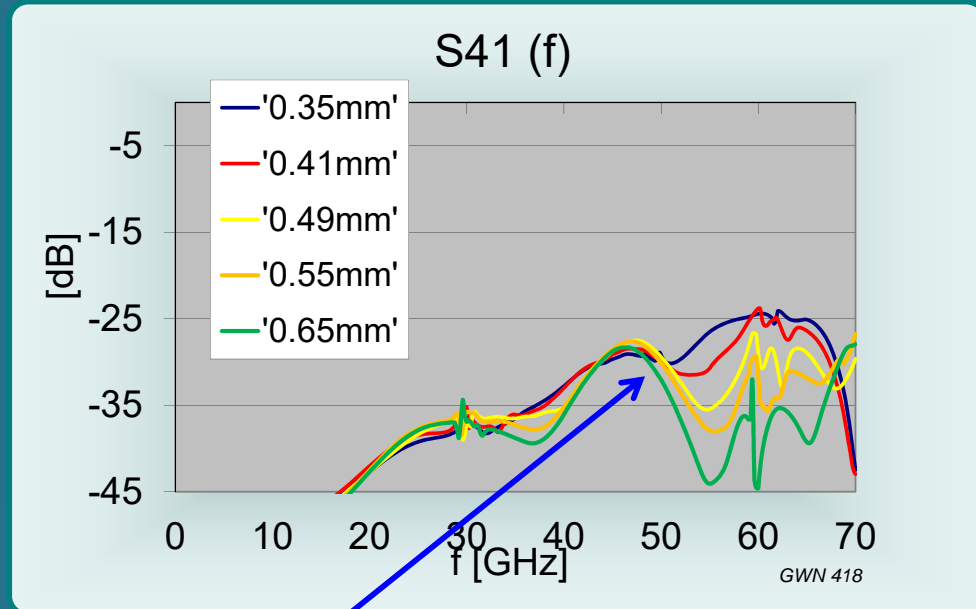
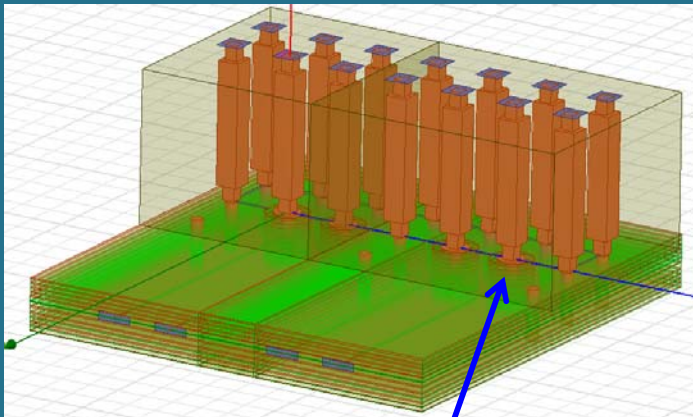
Ground vias, while generally needed, can actually increase crosstalk

Crosstalk (all) as a function of configuration



Coupling is reduced for greater spacing between aggressor and victim below 20 GHz
Coupling may increase with increasing spacing at higher frequencies

FEXT as a function of antipad size

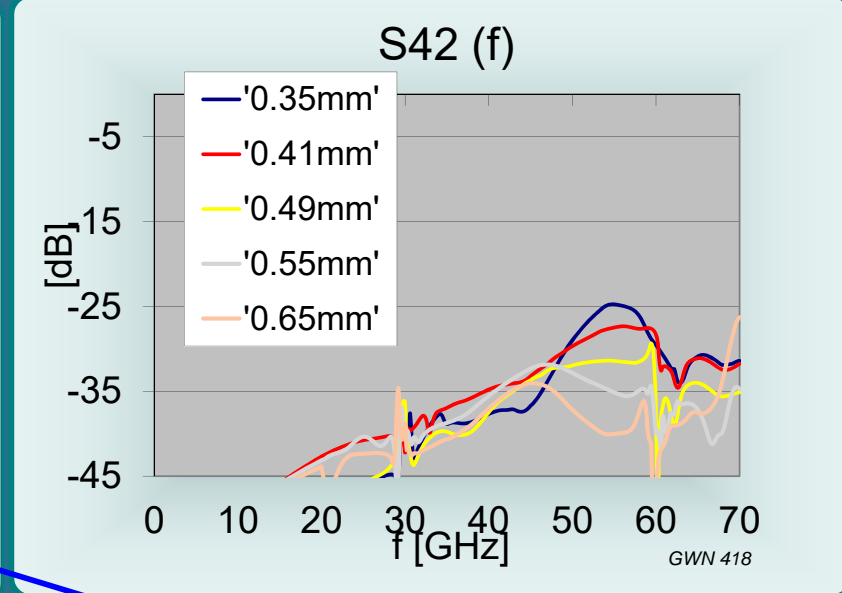
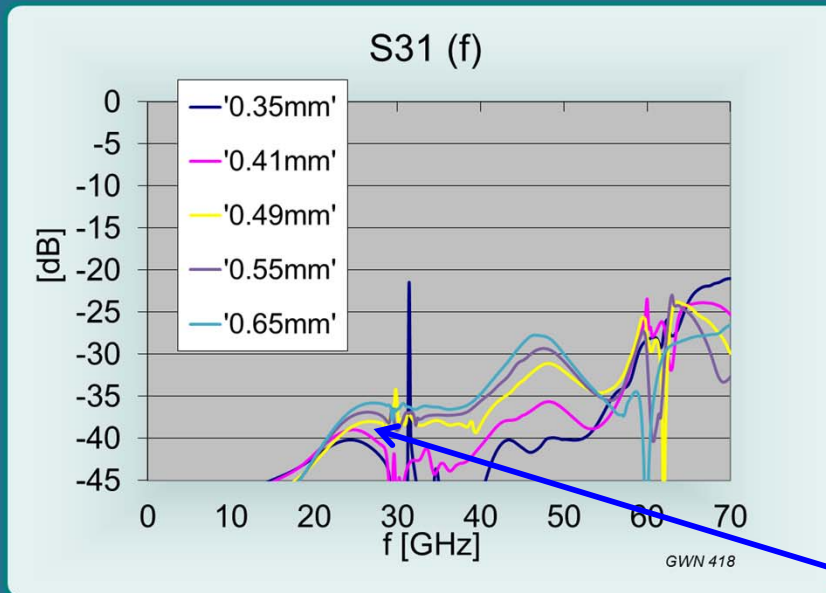


Noticeable impact above 50 GHz

optimal antipad size (0.41mm) for Sdd11 performance is **NOT** the best solution for crosstalk



NEXT as a function of antipad size

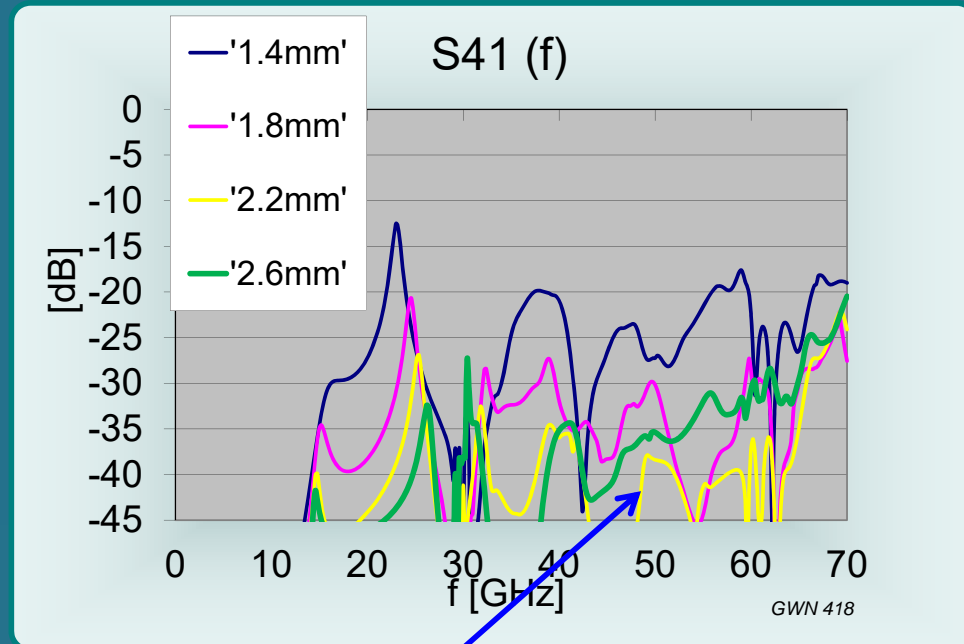
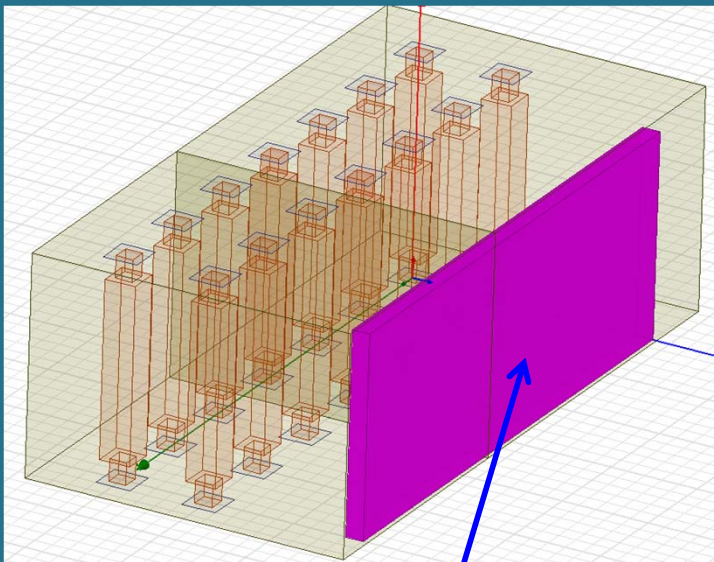


Noticeable impact above **25 GHz**

optimal antipad size for Sdd11 performance is **NOT** the best solution for crosstalk

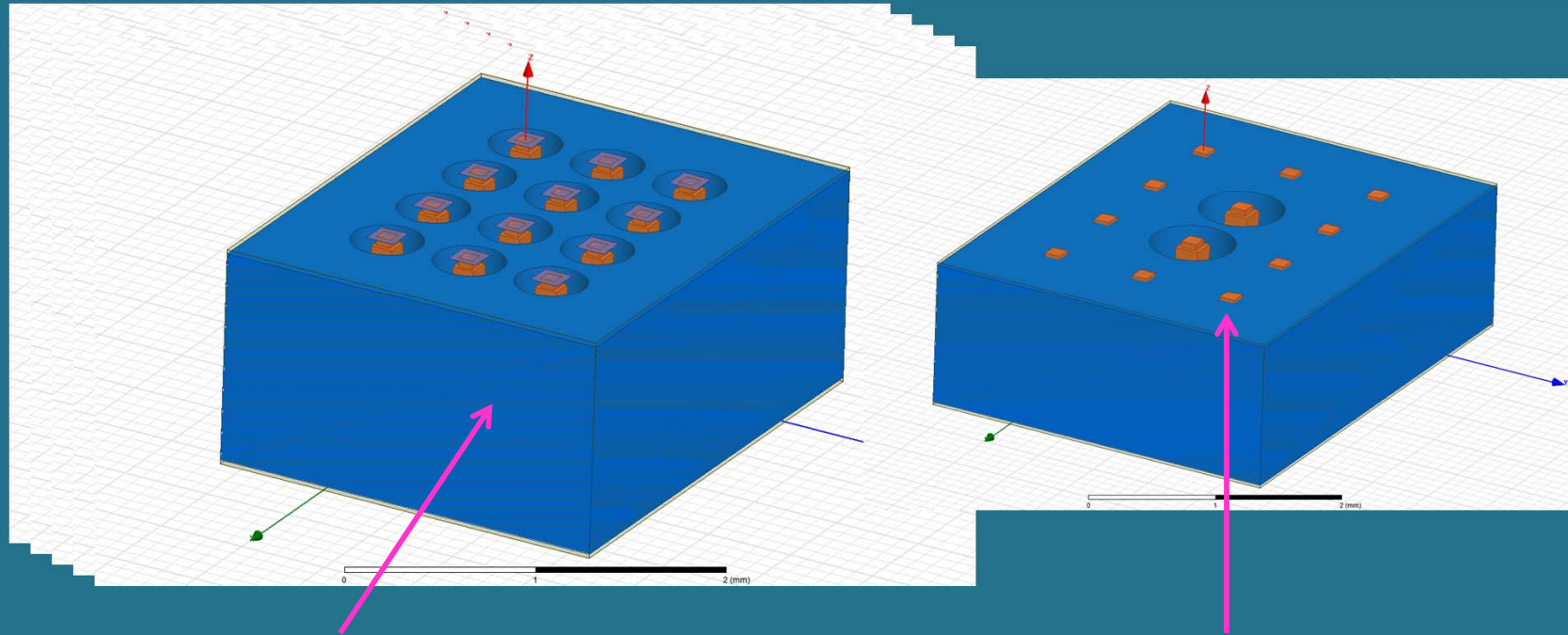


FEXT as a function of shield position



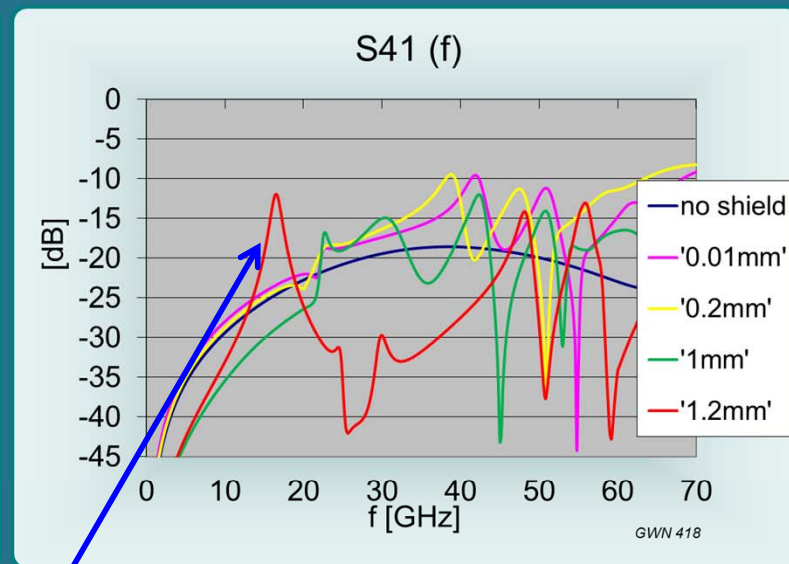
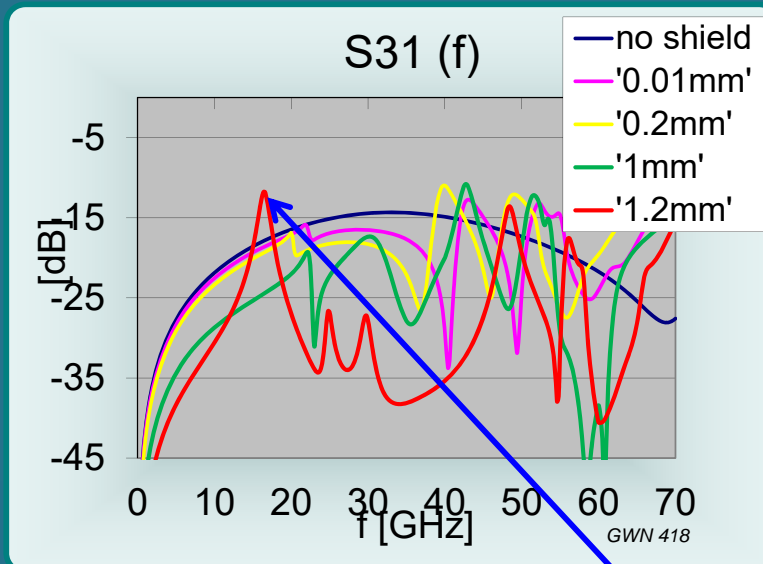
Shield position can reduce crosstalk over a range of frequencies
(in this case this is also true for NEXT)

Metal shields



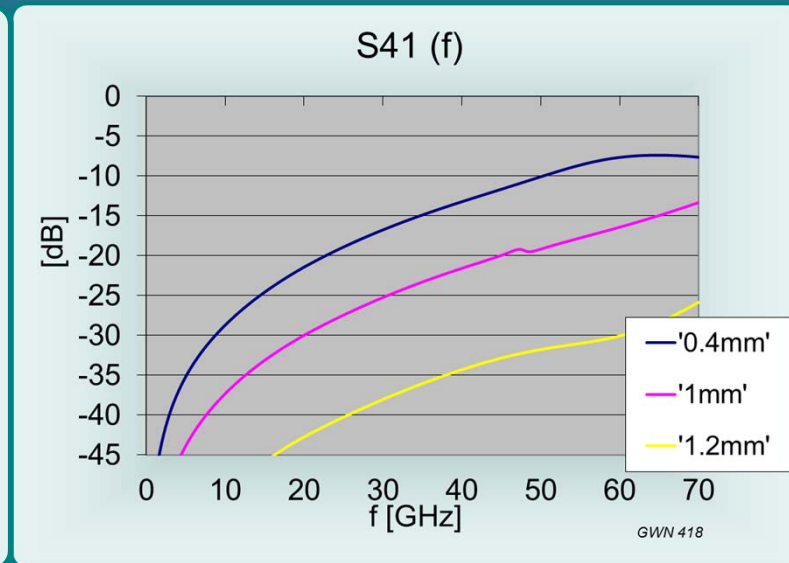
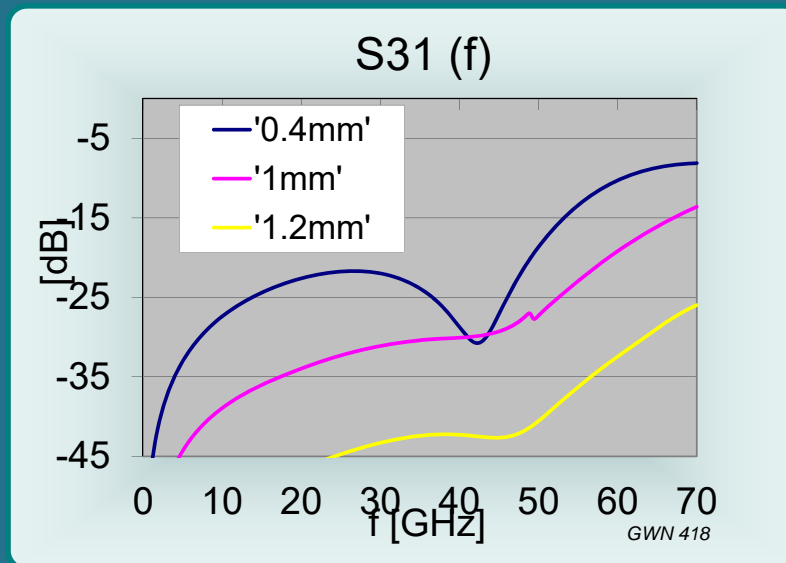
Cases: A) Shield thickness as variable B) ground connection to pins

Case A): NEXT and FEXT as a function of shield thickness



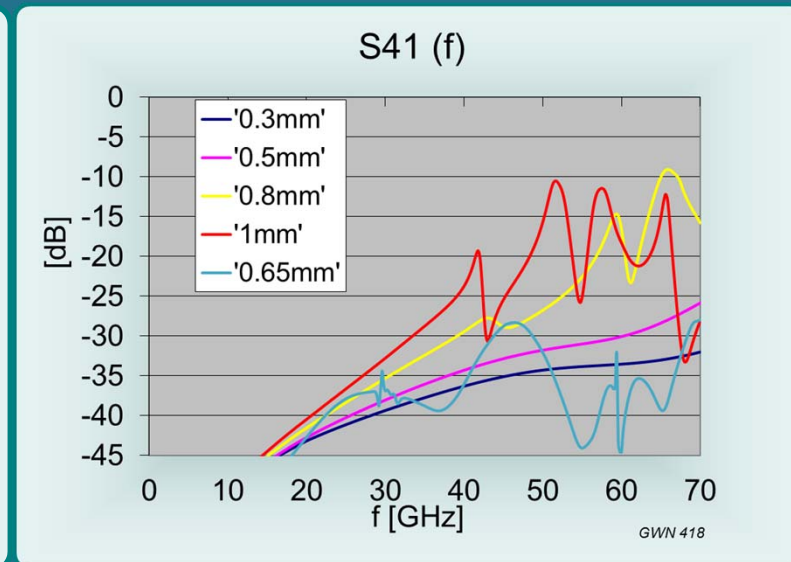
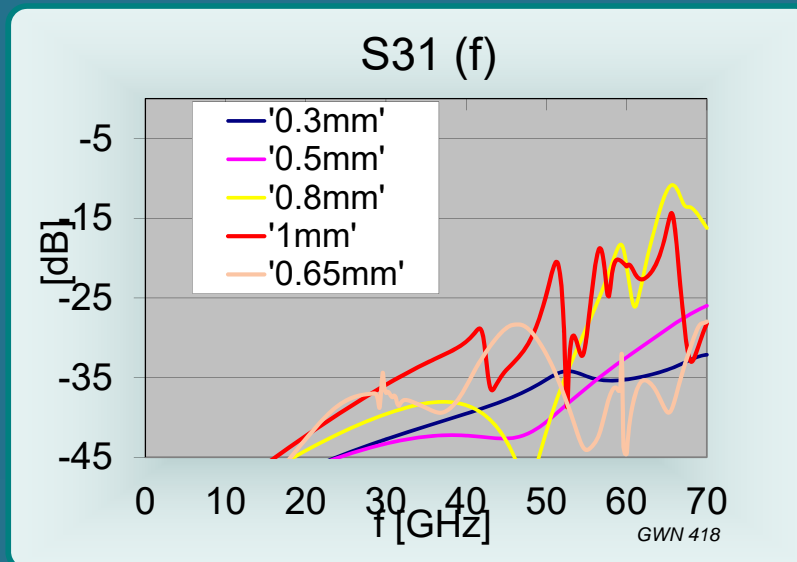
Improvements only possible to ~20 GHz
Noticeable peaks for thickest shield (!)

Case B): NEXT and FEXT as a function of grounded shield thickness



Best performance for thickest shield

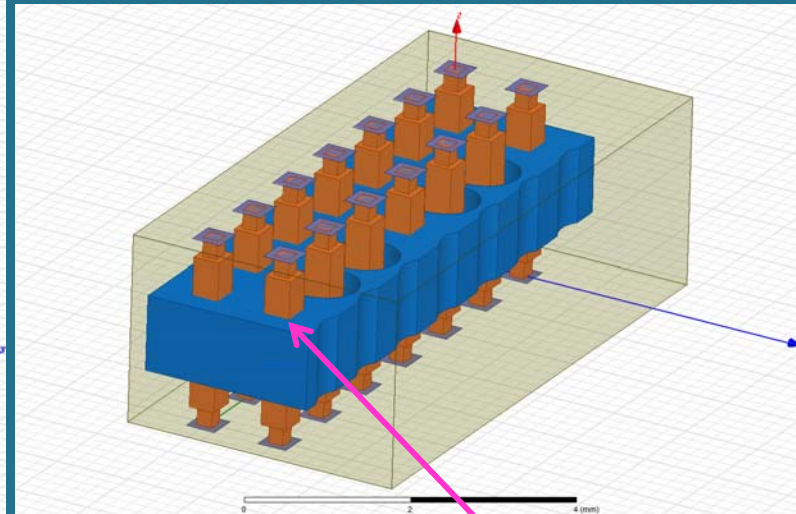
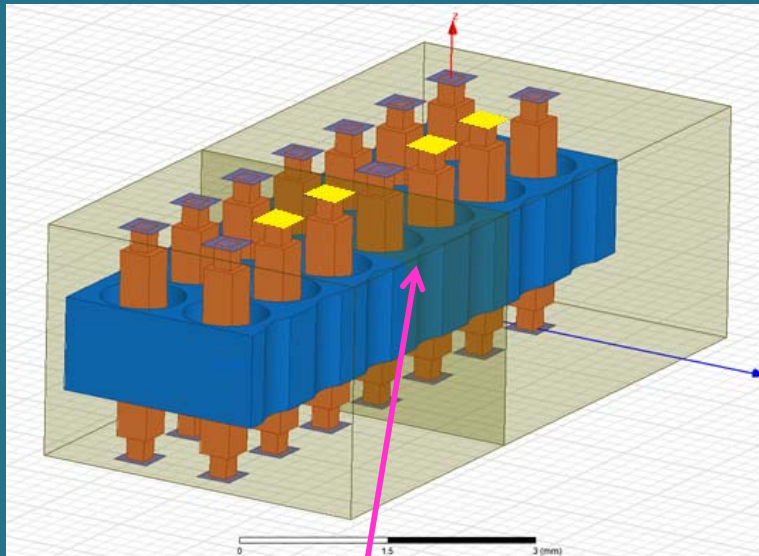
Case B): NEXT and FEXT as a function of pitch (full height shield)



Best performance for 0.3 mm and 0.5 mm pitch

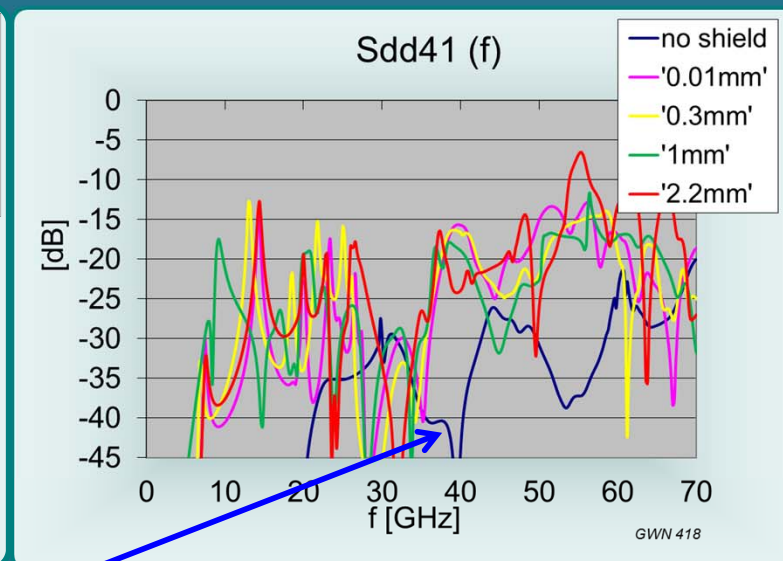
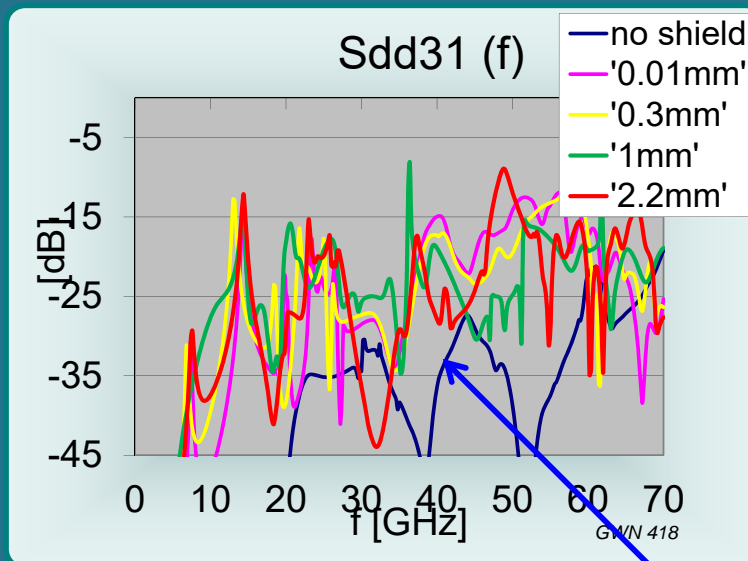


Metal shield, differential configuration



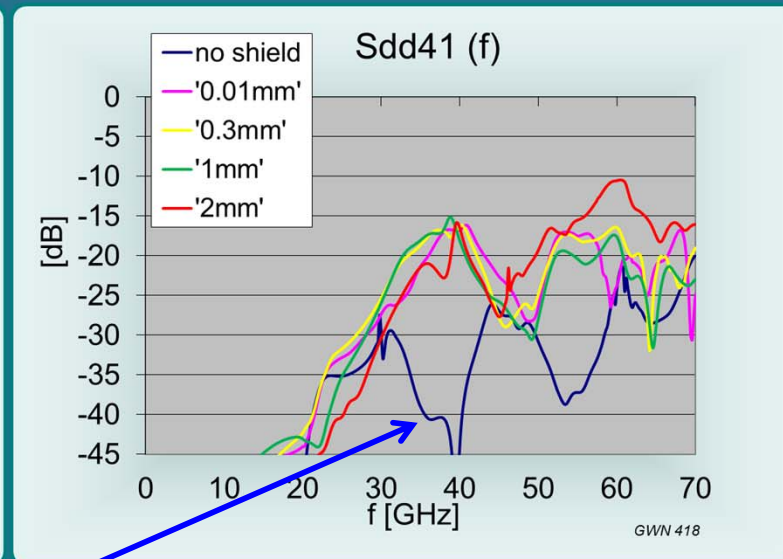
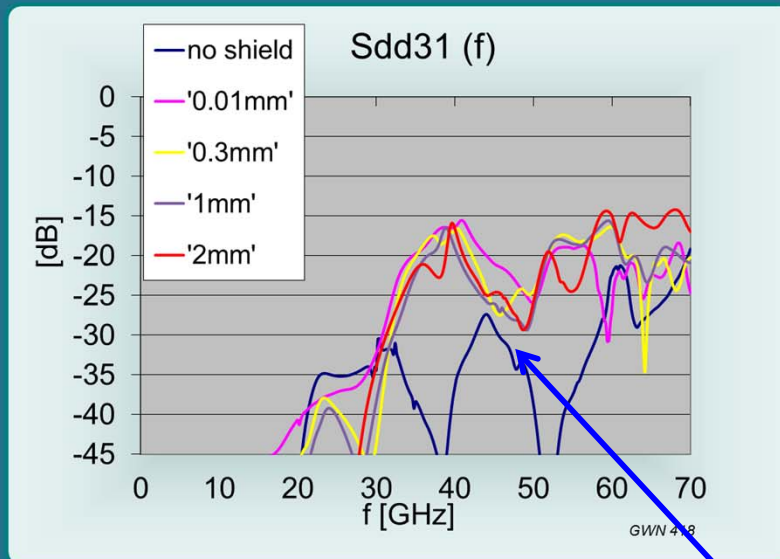
Cases: C) Shield thickness as variable D) ground connection to pins

Case C): NEXT and FEXT as a function of shield thickness



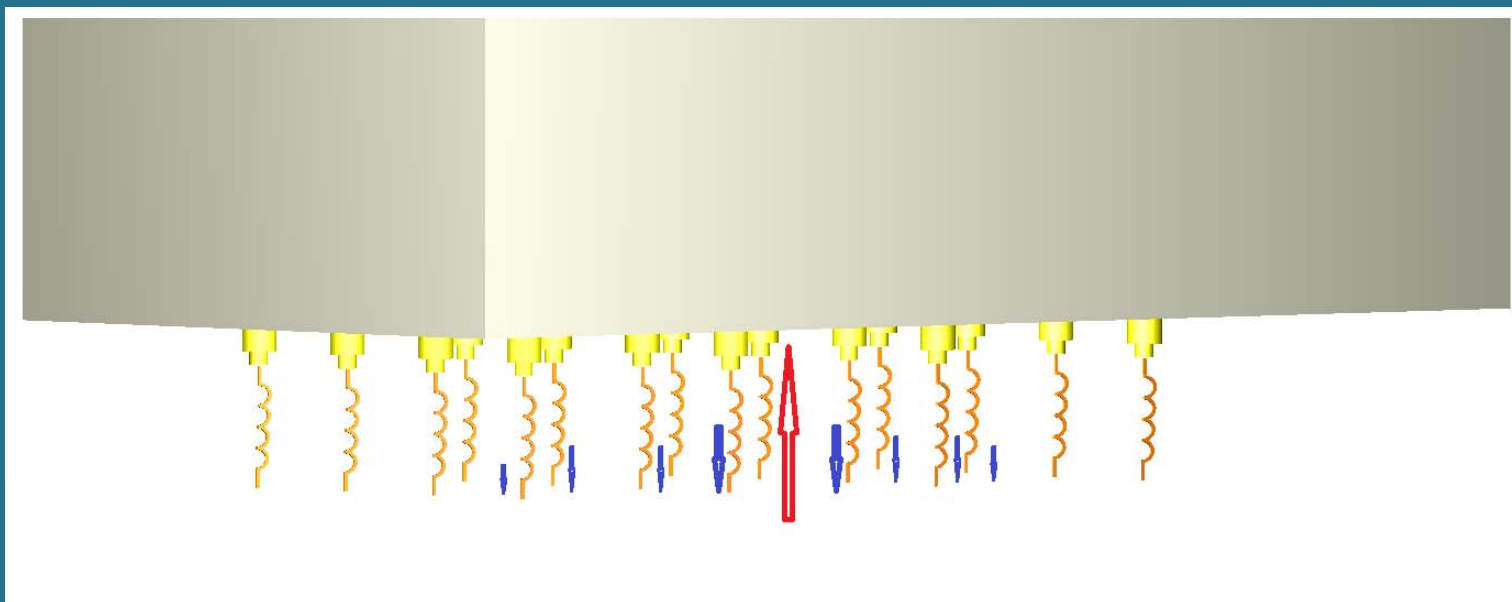
No improvements possible (!) compared to 'no shield' case

Case D): NEXT and FEXT as a function of grounded shield thickness



No improvements possible (!) compared to 'no shield' case

Cause of crosstalk in case of metal body



Ground return current couples into adjacent pins

Observations

- Pitch reduction reduces crosstalk
- Increasing contact length generally increases crosstalk
- Impedance near 50 Ohms yields best results
- Short interconnect can be worse than moderate length (this is likely due to field configuration / parasitics)



Comments

- Single-ended crosstalk is shown to establish trends
- Can (with caution) be applied to differential configurations
- Crosstalk improvements from various shielding efforts were not shown to be conclusive (differential signaling) and must be individually assessed according to frequency range and configuration

Conclusion

- Surprising / unexpected results make careful analysis mandatory.
- Interaction with PCB routing requires inclusion in analysis of initial design for optimal performance.

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